Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/654,893	HAYASE, KIYOSHI
Examiner	Art Unit

Joseph Schell

2114

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IEEE - see search notes	5/15/2007	JS		
EAST - see search notes limited search 714/10,31,1-57	5/16/2007	JS		